## Notice of References Cited Application/Control No. 10/088,030 Applicant(s)/Patent Under Reexamination ALLAWAY ET AL. Examiner Sharad Rampuria Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,950,129 A	09-1999	Schmid et al.	455/431
	В	US-6,408,180 B1	06-2002	McKenna et al.	455/431
	С	US-6,321,084 B1	11-2001	Horrer, Matthias	455/431
	D	US-2001/0011016	08-2001	CHAMBERS, PAUL	455/417
	E	US-6,002,929 A	12-1999	Bishop et al.	455/431
	F	US-6,603,967 B1	08-2003	Sinivaara et al.	455/431
	G	US-6,055,425 A	04-2000	Sinivaara, Hasse Kristian	455/431
	н	US-6,529,706 B1	03-2003	Mitchell, James P.	455/12.1
	1	US-6,463,278 B2	10-2002	Kraft et al.	455/418
	J	US-6,611,682 B1	08-2003	Projtz, Fredrik	455/417
	к	US-			
	L	US-		·	
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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